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COMPLIANT

N-Channel 500V (D-S) Super Junction Power MOSFET

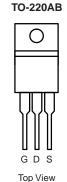
PRODUCT SUMMARY				
V _{DS} (V) at T _J max.	500			
R _{DS(on)} max. at 25 °C (Ω)	V _{GS} = 10 V	0.380		
Q _g max. (nC)	50			
Q _{gs} (nC)	6			
Q _{gd} (nC)	10			
Configuration	Single			

FEATURES

- Low figure-of-merit (FOM) Ron x Qq
- Low input capacitance (Ciss)
- Reduced switching and conduction losses
- Low gate charge (Q_q)
- Avalanche energy rated (UIS)

APPLICATIONS

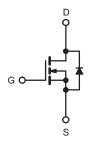
- Computing
 - PC silver box / ATX power supplies
- Lighting
 - Two stage LED lighting
- Consumer electronics







Top View



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)							
PARAMETER			SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V _{DS}	500	V			
Gate-Source Voltage			V_{GS}	± 30	V		
Continuous Drain Current (T _J = 150 °C)	V at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$	_	11			
	V _{GS} at 10 V	T _C = 100 °C	I _D	6.6	Α		
Pulsed Drain Current ^a			I _{DM}	21			
Linear Derating Factor				0.91	W/°C		
Single Pulse Avalanche Energy b			E _{AS}	103	mJ		
Maximum Power Dissipation			P_{D}	114	W		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +150	°C			
Drain-Source Voltage Slope	$V_{DS} = 0 V t$	o 80 % V _{DS}	70		V/ns		
Reverse Diode dV/dt ^d		dV/dt	27	V/IIS			
Soldering Recommendations (Peak Temperature) c	for 10 s			300	°C		

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 28.2 mH, R_q = 25 Ω , I_{AS} = 2.7 A.
- c. 1.6 mm from case.
- d. $I_{SD} \leq I_{D}, \; dI/dt = 100 \; A/\mu s, \; starting \; T_{J} = 25 \; ^{\circ}C.$

THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62	°C/W	
Maximum Junction-to-Case (Drain)	R_{thJC}	-	1.1	C/VV	



DTN11N50SJ/DTP11N50SJ/DTP11N50FSJ

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PARAMETER	SYMBOL	TES	TEST CONDITIONS		TYP.	MAX.	UNIT
Static		_				L	l
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		500	-	-	٧
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		-	0.60	-	V/°C
Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} =	V _{DS} = V _{GS} , I _D = 250 μA		-	4.0	V
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 20 V		-	-	± 100	nA
			V _{GS} = ± 30 V		-	± 1	μA
Zoro Coto Voltago Duoin Current		V _{DS} =	$V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V}$		-	1	μΑ
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 400 V	V _{DS} = 400 V, V _{GS} = 0 V, T _J = 125 °C		-	10	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 6 A	-	0.380	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} = 30 V, I _D = 6 A		-	3.1	-	S
Dynamic				•			
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 100 \text{ V},$ f = 1 MHz		-	886	-	pF
Output Capacitance	C _{oss}			-	52	-	
Reverse Transfer Capacitance	C _{rss}			-	6	-	
Effective Output Capacitance, Energy Related ^a	C _{o(er)}	V _{DS} = 0 V to 400 V, V _{GS} = 0 V		-	45	-	
Effective Output Capacitance, Time Related ^b	C _{o(tr)}			-	131	-	
Total Gate Charge	Qg			-	25	50	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 6 \text{ A}, V_{DS} = 400 \text{ V}$		6	-	nC
Gate-Drain Charge	Q _{gd}				10	-	
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 400 \text{ V}, I_{D} = 6 \text{ A},$ $V_{GS} = 10 \text{ V}, R_{g} = 9.1 \Omega$		-	13	26	ns
Rise Time	t _r			-	16	32	
Turn-Off Delay Time	t _{d(off)}			-	29	58	
Fall Time	t _f			-	12	24	
Gate Input Resistance	R _g	f = 1 MHz, open drain		-	0.92	-	Ω
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	11	
Pulsed Diode Forward Current	I _{SM}			-	-	21	A
Diode Forward Voltage	V _{SD}	T _J = 25 °C, I _S = 7.5 A, V _{GS} = 0 V		-	-	1.2	V
Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = I _S = 6 A, dl/dt = 100 A/ μ s, V _R = 25 V		-	244	-	ns
Reverse Recovery Charge	Q _{rr}			-	2.5	-	μC
Reverse Recovery Current	I _{RRM}			-	19	-	A

- a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

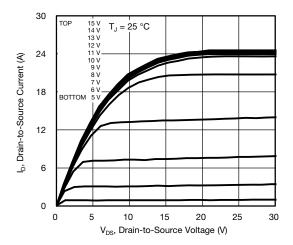


Fig. 1 - Typical Output Characteristics

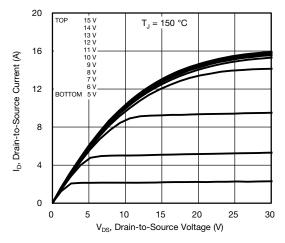


Fig. 2 - Typical Output Characteristics

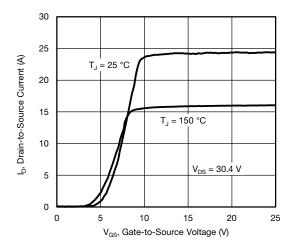


Fig. 3 - Typical Transfer Characteristics

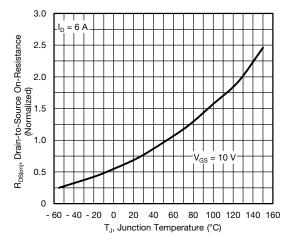


Fig. 4 - Normalized On-Resistance vs. Temperature

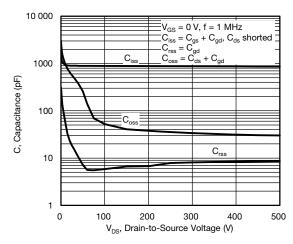


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

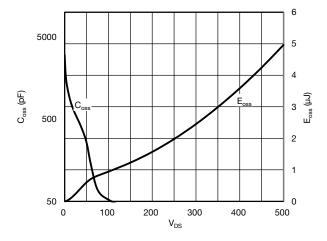


Fig. 6 - C_{oss} and E_{oss} vs. V_{DS}



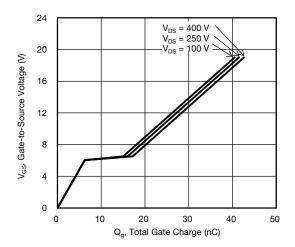


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

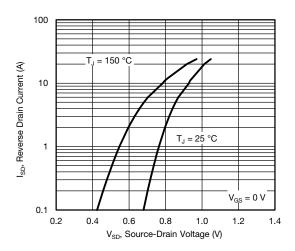


Fig. 8 - Typical Source-Drain Diode Forward Voltage

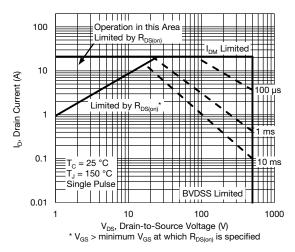


Fig. 9 - Maximum Safe Operating Area

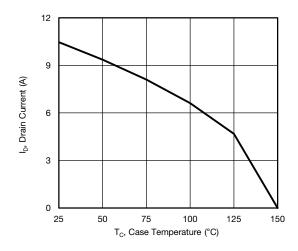


Fig. 10 - Maximum Drain Current vs. Case Temperature

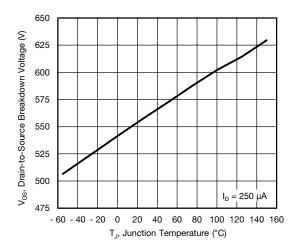


Fig. 11 - Temperature vs. Drain-to-Source Voltage



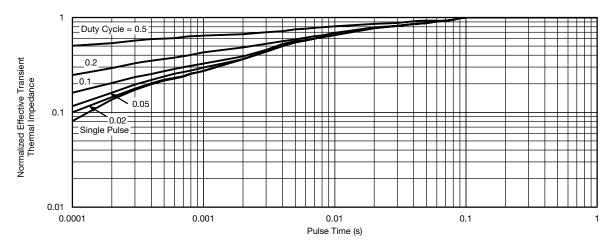


Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case

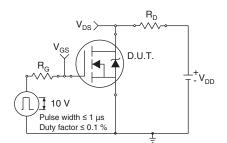


Fig. 13 - Switching Time Test Circuit

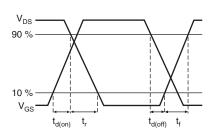


Fig. 14 - Switching Time Waveforms

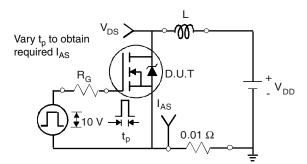


Fig. 15 - Unclamped Inductive Test Circuit

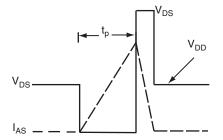


Fig. 16 - Unclamped Inductive Waveforms

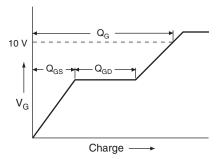


Fig. 17 - Basic Gate Charge Waveform

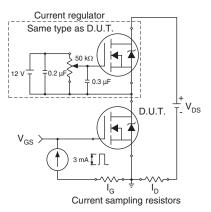
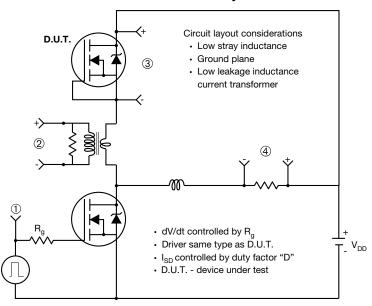


Fig. 18 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



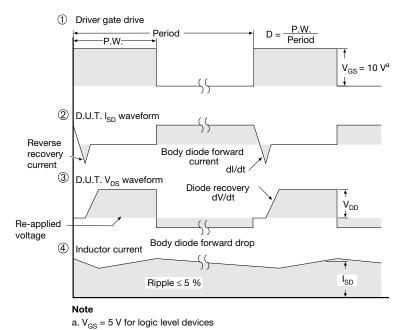


Fig. 19 - For N-Channel





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